

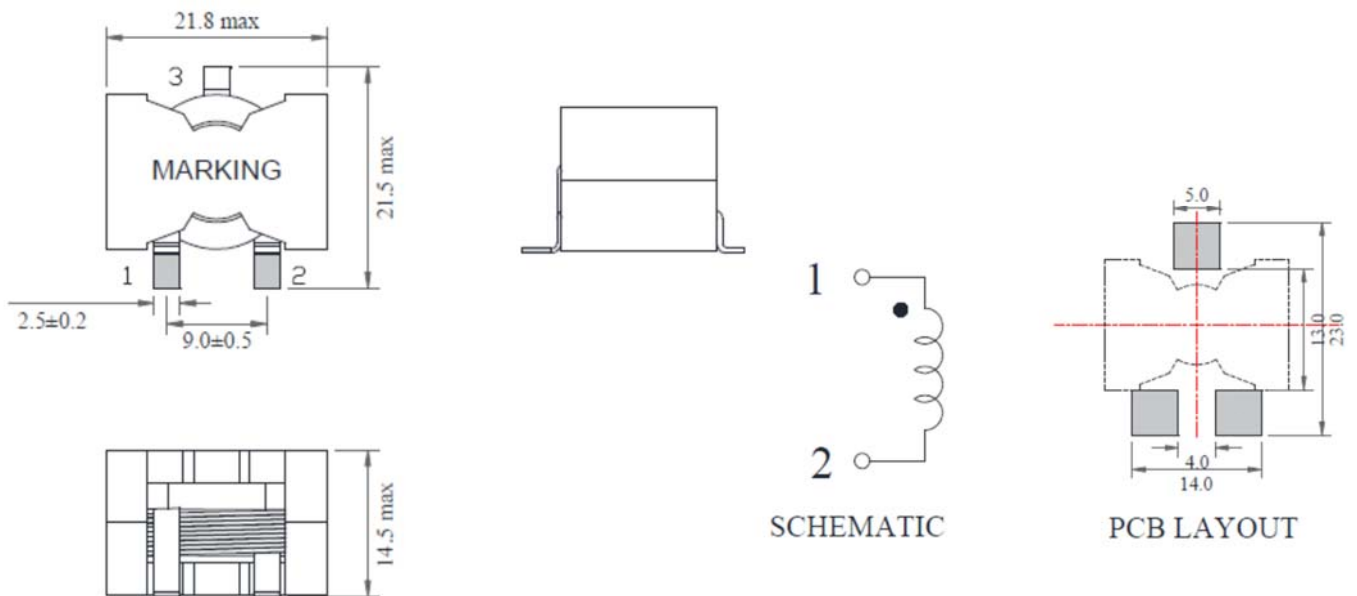
## FEATURES

- Susing flat wire, and SMD type.
- Low radiation noise by magnetically shielded construction
- High current, Low resistance.
- Operating temperature :  $-40^{\circ}\text{C} \sim +125^{\circ}\text{C}$ .

## APPLICATIONS

- high efficiency DC/DC converters.
- Single and polyphase buck converters.
- Filter for audio applications.
- Optimized for high current boost applications.

## CONFIGURATIONS & DIMENSIONS ( unit in mm )



## ELECTRICAL CHARACTERISTICS

Part number	Inductance $\mu\text{H}$	DC resistance $\text{m}\Omega$ max. (typ.)	DC saturation current A max.(typ.)			Temperature rise current A max.(typ.)	
			$\Delta L \leq 10\%$	$\Delta L \leq 20\%$	$\Delta L \leq 30\%$	$\Delta T \leq 20^{\circ}\text{C}$	$\Delta T \leq 40^{\circ}\text{C}$
HAPH20-701M	$0.7 \pm 20\%$	1.0(0.7)	70(75)	75(79)	77.5(81)	22	28
HAPH20-152M	$1.5 \pm 20\%$	1.3(1.05)	57(60)	60(63.5)	62(65.2)	21	26.5
HAPH20-222M	$2.2 \pm 20\%$	1.8(1.5)	48(51.5)	52(56)	53.5(57)	20	25
HAPH20-332M	$3.3 \pm 20\%$	2.5(2.1)	40(44)	45(47)	46.5(48)	18.5	23.5

HAPH20-472M	4.7±20%	3.6(3.1)	30(34.5)	35(37)	36.5(38)	15.5	22
HAPH20-682M	4.7±20%	6.8(5.2)	25(29.7)	30(32)	31.5(33)	13.5	19
HAPH20-103K	10±10%	9.5(7.3)	18(22.8)	23(24.8)	24(25.6)	10	14
HAPH20-153K	15±10%	10.5(8.7)	17(20.6)	21(22.5)	22(23.4)	9	12.5
HAPH20-223K	22±10%	12.8(10.6)	12.5(15)	15(16.3)	15.8(17.1)	7	11
HAPH20-333K	33±10%	13.7(11.5)	8.5(11)	11(12.1)	11.7(12.9)	6	10

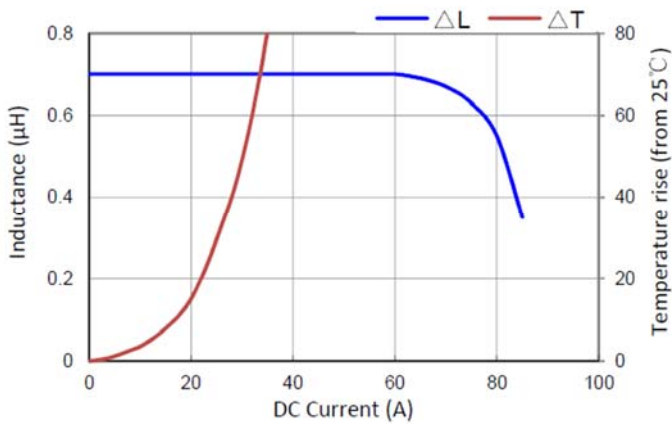
### Remark

Inductance is measured with a LCR meter 4284A or equivalent. Test frequency at 100kHz

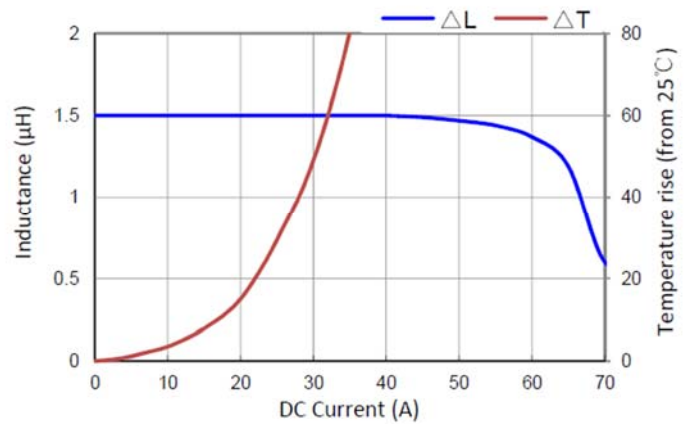
DC resistance is measured with 16502 Milliohm Meter , or equivalent. Reference ambient temperature 25°C

## Electrical Characteristic Curve

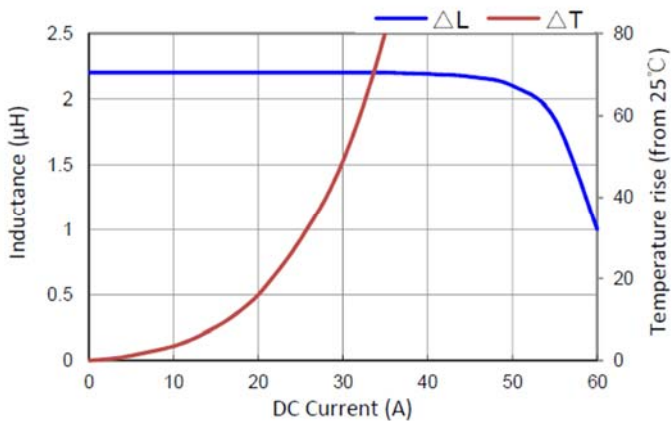
HAPH20-701



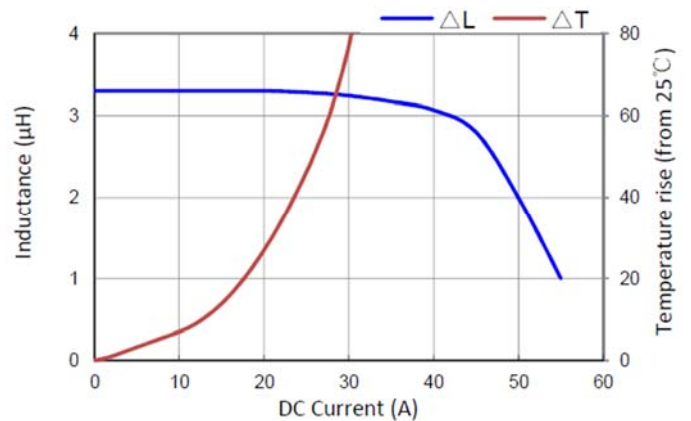
HAPH20-152



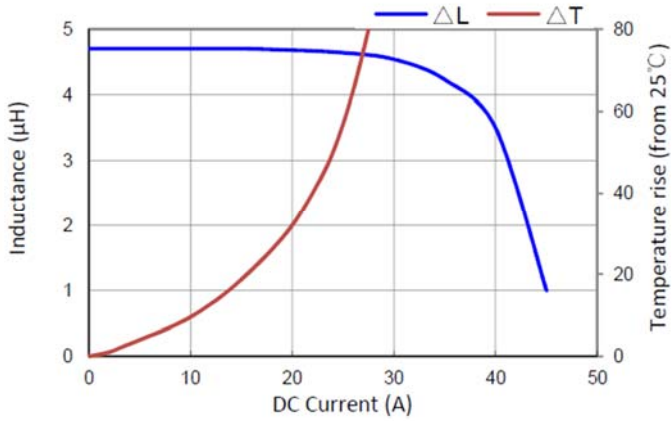
HAPH20-222



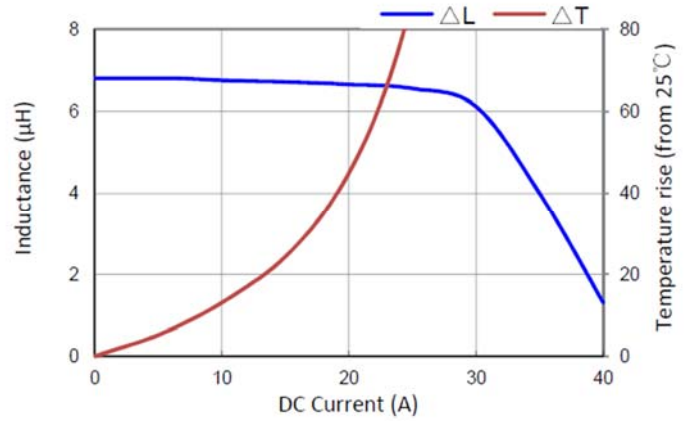
HAPH20-332



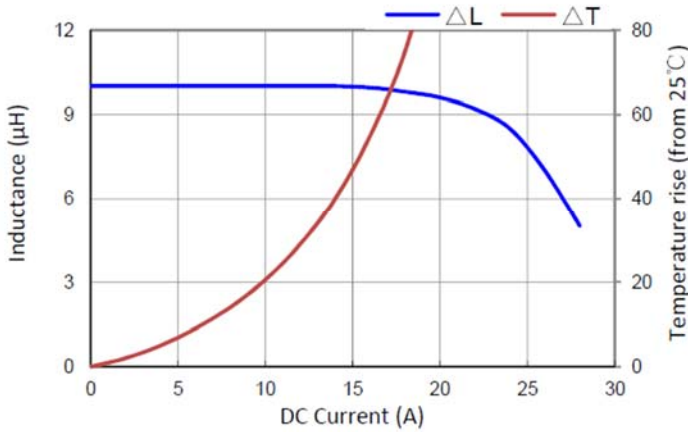
**HAPH20-472**



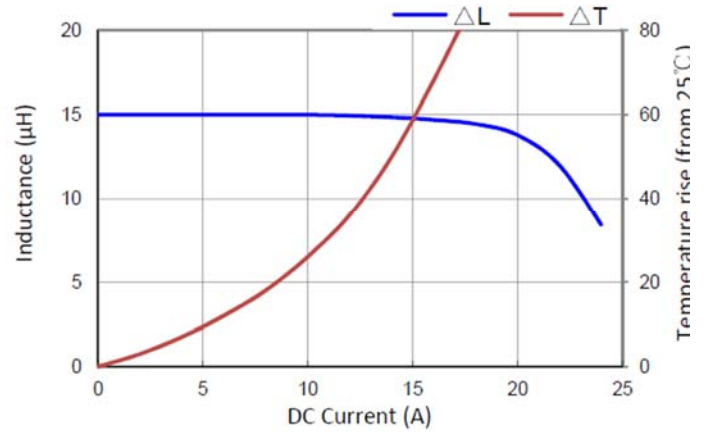
**HAPH20-682**



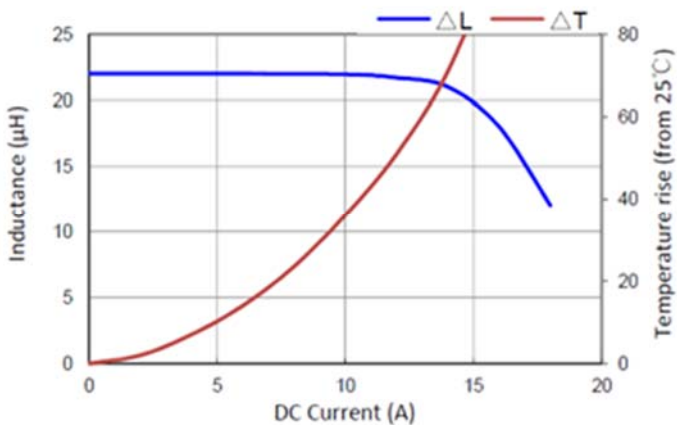
**HAPH20-103**



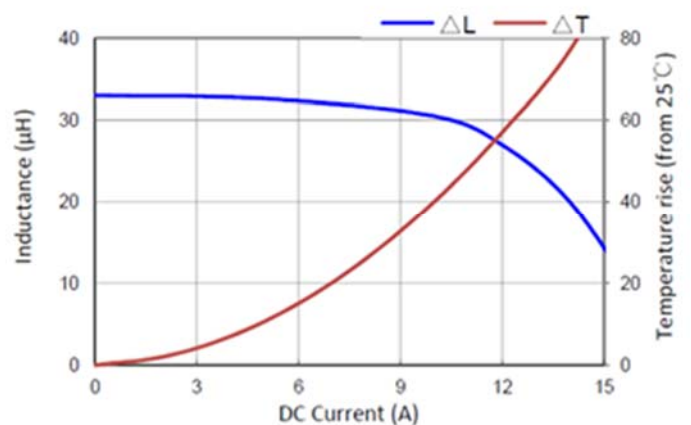
**HAPH20-153**



**HAPH20-223**

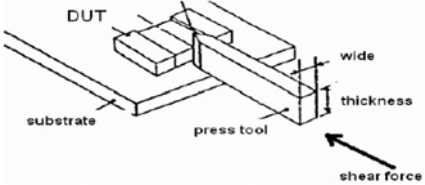


**HAPH20-223**



## Reliability and Test Condition

Item	Performance	Test Condition															
Operating temperature	-40~+125°C (Including self - temperature rise)																
Storage temperature	1. -10~+40°C, 50~60%RH (Product with taping) 2. -40~+125°C (on board)																
<b>Electrical Performance Test</b>																	
Inductance	Refer to standard electrical characteristics list.	HP4284A, CH11025, CH3302, CH1320, CH1320S LCR Meter.															
DCR		CH16502, Agilent33420A Micro-Ohm Meter.															
Saturation Current (Isat)	Approximately $\Delta L30\%$	Saturation DC Current (Isat) will cause L0 to drop $\Delta L(\%)$															
Heat Rated Current (Irms)	Approximately $\Delta T40^{\circ}\text{C}$	Heat Rated Current (Irms) will cause the coil temperature rise $\Delta T(^{\circ}\text{C})$ . 1. Applied the allowed DC current 2. Temperature measured by digital surface thermometer															
<b>Reliability Test</b>																	
Life Test	Appearance : No damage. Inductance : within $\pm 10\%$ of initial value Q : Shall not exceed the specification value. RDC : within $\pm 15\%$ of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020D Classification Reflow Profiles) Temperature : $125\pm 2^{\circ}\text{C}$ (Inductor) Applied current : rated current Duration : 1000 $\pm$ 12hrs Measured at room temperature after placing for 24 $\pm$ 2 hrs															
Load Humidity		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020D Classification Reflow Profiles) Humidity : 85 $\pm$ 2%R.H, Temperature : $85^{\circ}\text{C}\pm 2^{\circ}\text{C}$ Duration : 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24 $\pm$ 2 hrs															
Moisture Resistance		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020D Classification Reflow Profiles) 1. Baked at $50^{\circ}\text{C}$ for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to $65\pm 2^{\circ}\text{C}$ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to $25^{\circ}\text{C}$ in 2.5hrs. 3. Raise temperature to $65\pm 2^{\circ}\text{C}$ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to $25^{\circ}\text{C}$ in 2.5hrs, keep at $25^{\circ}\text{C}$ for 2 hrs then keep at $-10^{\circ}\text{C}$ for 3 hrs 4. Keep at $25^{\circ}\text{C}$ 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.															
Thermal shock		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020D Classification Reflow Profiles) Condition for 1 cycle Step1 : $-40\pm 2^{\circ}\text{C}$ 30 $\pm$ 5min Step2 : $25\pm 2^{\circ}\text{C}$ $\leq$ 0.5min Step3 : $125\pm 2^{\circ}\text{C}$ 30 $\pm$ 5min Number of cycles : 500 Measured at room temperature after placing for 24 $\pm$ 2 hrs															
Vibration		Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment : Vibration checker Total Amplitude: 1.52mm $\pm$ 10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations).															
Bending		Shall be mounted on a FR4 substrate of the following dimensions: $\geq 0805$ inch(2012mm):40x100x1.2mm $< 0805$ inch(2012mm):40x100x0.8mm Bending depth: $\geq 0805$ inch(2012mm):1.2mm $< 0805$ inch(2012mm):0.8mm duration of 10 sec.															
Shock	Appearance : No damage. Impedance : within $\pm 15\%$ of initial value Inductance : within $\pm 10\%$ of initial value Q : Shall not exceed the specification value. RDC : within $\pm 15\%$ of initial value and shall not exceed the specification value	<table border="1"> <thead> <tr> <th>Type</th> <th>Peak value (g/s)</th> <th>Normal duration (D) (ms)</th> <th>Wave form</th> <th>Velocity change (Vi)ft/sec</th> </tr> </thead> <tbody> <tr> <td>SMD</td> <td>50</td> <td>11</td> <td>Half-sine</td> <td>11.3</td> </tr> <tr> <td>Lead</td> <td>50</td> <td>11</td> <td>Half-sine</td> <td>11.3</td> </tr> </tbody> </table>	Type	Peak value (g/s)	Normal duration (D) (ms)	Wave form	Velocity change (Vi)ft/sec	SMD	50	11	Half-sine	11.3	Lead	50	11	Half-sine	11.3
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SMD	50	11	Half-sine	11.3													
Lead	50	11	Half-sine	11.3													
Solder ability	More than 95% of the terminal electrode should be covered with solder.	Preheat: $150^{\circ}\text{C}$ , 60sec. Solder: Sn96.5% Ag3% Cu0.5% Temperature: $245\pm 5^{\circ}\text{C}$															

		Flux for lead free: Rosin, 9.5% Dip time: 4±1sec Depth: completely cover the termination								
Resistance to Soldering Heat		Depth: completely cover the termination  <table border="1" data-bbox="1023 311 1453 427"> <thead> <tr> <th>Temperature(°C)</th> <th>Time(s)</th> <th>Temperature ramp/immersion and emersion rate</th> <th>Number of heat cycles</th> </tr> </thead> <tbody> <tr> <td>260 ±5 (solder temp)</td> <td>10 ±1</td> <td>25mm/s ±6 mm/s</td> <td>1</td> </tr> </tbody> </table>	Temperature(°C)	Time(s)	Temperature ramp/immersion and emersion rate	Number of heat cycles	260 ±5 (solder temp)	10 ±1	25mm/s ±6 mm/s	1
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260 ±5 (solder temp)	10 ±1	25mm/s ±6 mm/s	1							
Terminal Strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value e	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020Classification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force(>0805:1kg , <=0805:0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.  								

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.